

TEST REPORT EN 60947-2

Low-voltage switchgear and controlgear - Part 2: Circuit-breakers

Date of issue.....: 2024-02-26

Total number of pages...... 138

Name of Testing Laboratory Shanghai Testing & Inspection Institute for Electrical Equipment

preparing the Report...... Co.,Ltd. (STIEE)

Applicant's name Zhejiang Tengen Electric Co., Ltd.

Address Sulv Industrial Area, Liushi Town, Yueqing City, Zhejiang Province,

P.R.China

Test specification:

Standard.....: EN 60947-2:2017/A1:2020

Test procedure: CCA

Non-standard test method: N/A

Test Report Form No.: 60947_2K

Test Report Form(s) Originator: DEKRA Certification B.V.

Master TRF.....: Dated 2023-09-14

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Test item description:		Moulded Case Circuit-breakers		
Trade Mark(s):		TENGEN		
Manufacturer:		Zhejiang Tengen Electric Co., Ltd. Sulv Industrial Area, Liushi Town, Yueqing City, Zhejiang Province, P.R.China		
		TGM1E□-400L,TGM1E□-400Y,TGM1E□-400M, TGM1E□-400H,TGM3E□-400L,TGM3E□-400Y, TGM3E□-400M,TGM3E□-400H		
Ratings: See p		See pa	age 25	
Responsible Testing Laboratory (as applicable), testing procedure and testing location(s):				
▼ Testing Laboratory:		Shanghai Testing & Inspection Institute for Electrical Equipment Co.,Ltd.(STIEE)		
Testing location/ address:		505 Wu Ning Rd. Shanghai 200063, P.R. CHINA		
Tested by (name, function, signature):		Liu Wei/Engineer	刘威	
Approved by (name, function, signature):		Yin Jifu/Senior engineer	倒去福	
	Testing procedure: CTF Stage 1	<u> </u>		
Testing location/ address:				
resting location, address				
Tested by (name, function, signature):				
Approved by (name, function, signature):				
Testing procedure: CTF Stage 2:				
Testing location/ address:				
Tested by (name + signature):				
Witnessed by (name, function, signature).:				
Approved by (name, function, signature):				
	Testing procedure: CTF Stage 3			
Testing procedure: CTF Stage 4:				
Testing location/ address:				
Tested by (name, function, signature):				
Witnessed by (name, function, signature).:				
Approved by (name, function, signature):				
Supervised by (name, function, signature) :				_